

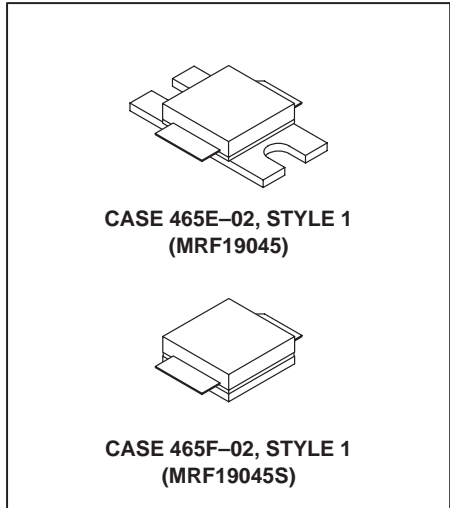
The RF MOSFET Line
RF Power Field Effect Transistors
N-Channel Enhancement-Mode Lateral MOSFETs



Designed for PCN and PCS base station applications from frequencies up to 1.9 to 2.0 GHz. Suitable for TDMA, CDMA and multicarrier amplifier applications.

1990 MHz, 45 W, 26 V
LATERAL N-CHANNEL
BROADBAND
RF POWER MOSFETs

- Typical CDMA Performance @ 1960 MHz, 26 Volts, I_{DQ} = 550 mA
Multi-carrier CDMA Pilot, Sync, Paging, Traffic Codes 8 Through 13
Output Power — 9.5 Watts Avg.
Power Gain — 14.9 dB
Efficiency — 23.5%
Adjacent Channel Power —
885 kHz: -50 dBc @ 30 kHz BW
IM3 — -37 dBc
- 100% Tested Under 2-Carrier N-CDMA
- Internally Matched, Controlled Q, for Ease of Use
- High Gain, High Efficiency and High Linearity
- Integrated ESD Protection
- Ease of Design for Gain and Insertion Phase Flatness
- Capable of Handling 5:1 VSWR, @ 26 Vdc, 1.93 GHz, 45 Watts (CW) Output Power
- Excellent Thermal Stability
- Characterized with Series Equivalent Large-Signal Impedance Parameters



MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	V _{DSS}	65	Vdc
Gate-Source Voltage	V _{GS}	+15, -0.5	Vdc
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	105 0.60	Watts W/°C
Storage Temperature Range	T _{stg}	-65 to +200	°C
Operating Junction Temperature	T _J	200	°C

ESD PROTECTION CHARACTERISTICS

Test Conditions	Class
Human Body Model	2 (Typical)
Machine Model	M3 (Typical)

THERMAL CHARACTERISTICS

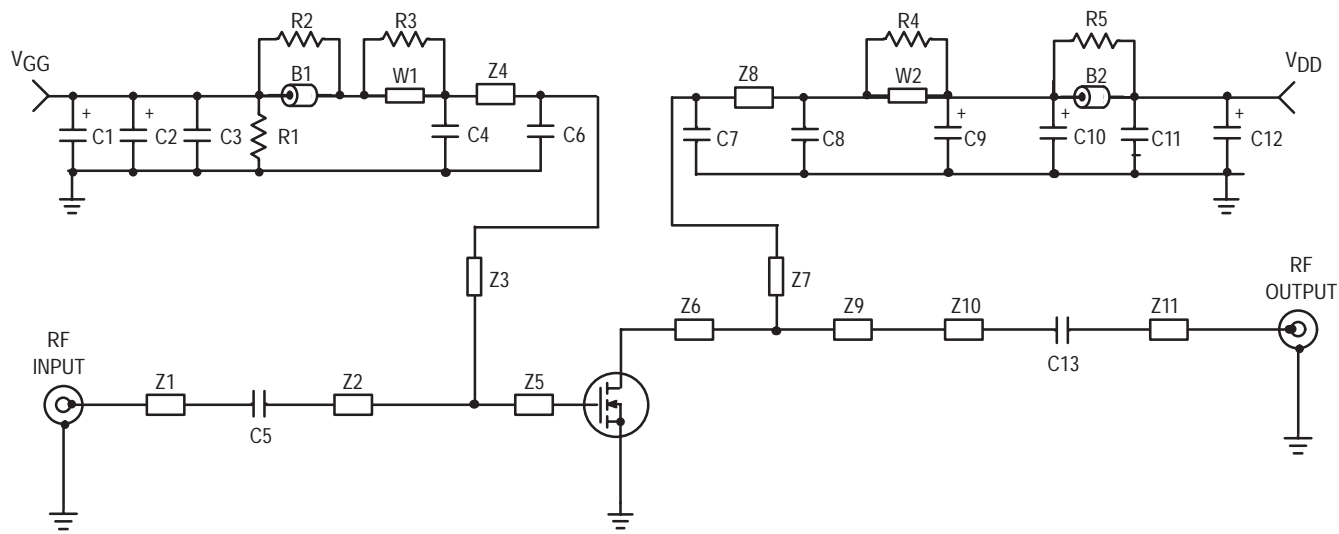
Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	R _{θJC}	1.65	°C/W

NOTE – **CAUTION** – MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Drain–Source Breakdown Voltage ($V_{GS} = 0\text{ Vdc}$, $I_D = 100\ \mu\text{Adc}$)	$V_{(BR)DSS}$	65	—	—	Vdc
Zero Gate Voltage Drain Current ($V_{DS} = 26\text{ Vdc}$, $V_{GS} = 0$)	I_{DSS}	—	—	10	μAdc
Gate–Source Leakage Current ($V_{GS} = 5\text{ Vdc}$, $V_{DS} = 0$)	I_{GSS}	—	—	1	μAdc
ON CHARACTERISTICS (DC)					
Gate Threshold Voltage ($V_{DS} = 10\text{ Vdc}$, $I_D = 100\ \mu\text{Adc}$)	$V_{GS(th)}$	2	—	4	Vdc
Gate Quiescent Voltage ($V_{DS} = 26\text{ Vdc}$, $I_D = 550\text{ mAdc}$)	$V_{GS(Q)}$	3	3.8	5	Vdc
Drain–Source On–Voltage ($V_{GS} = 10\text{ Vdc}$, $I_D = 1\text{ Adc}$)	$V_{DS(on)}$	—	0.19	0.21	Vdc
Forward Transconductance ($V_{DS} = 10\text{ Vdc}$, $I_D = 2\text{ Adc}$)	g_{fs}	—	4.2	—	S
DYNAMIC CHARACTERISTICS					
Reverse Transfer Capacitance (1) ($V_{DS} = 26\text{ Vdc}$, $V_{GS} = 0$, $f = 1.0\text{ MHz}$)	C_{rss}	—	1.8	—	pF
FUNCTIONAL TESTS (In Motorola Test Fixture) 2–carrier N–CDMA, 1.2288 MHz Channel Bandwidth, IM3 measured in 1.2288 MHz Integrated Bandwidth. ACPR measured in 30 kHz Integrated Bandwidth.					
Common–Source Amplifier Power Gain ($V_{DD} = 26\text{ Vdc}$, $P_{out} = 9.5\text{ W Avg}$, 2–Carrier N–CDMA, $I_{DQ} = 550\text{ mA}$, $f_1 = 1930\text{ MHz}$, $f_2 = 1932.5\text{ MHz}$ and $f_1 = 1987.5\text{ MHz}$, $f_2 = 1990\text{ MHz}$)	G_{ps}	13	14.5	—	dB
Drain Efficiency ($V_{DD} = 26\text{ Vdc}$, $P_{out} = 9.5\text{ W Avg}$, 2–Carrier N–CDMA, $I_{DQ} = 550\text{ mA}$, $f_1 = 1930\text{ MHz}$, $f_2 = 1932.5\text{ MHz}$ and $f_1 = 1987.5\text{ MHz}$, $f_2 = 1990\text{ MHz}$)	η	21	23.5	—	%
3rd Order Intermodulation Distortion ($V_{DD} = 26\text{ Vdc}$, $P_{out} = 9.5\text{ W Avg}$, 2–Carrier N–CDMA, $I_{DQ} = 550\text{ mA}$, $f_1 = 1930\text{ MHz}$, $f_2 = 1932.5\text{ MHz}$ and $f_1 = 1987.5\text{ MHz}$, $f_2 = 1990\text{ MHz}$; IM3 Measured in a 1.2288 MHz Integrated Bandwidth Centered at $f_1 - 2.5\text{ MHz}$ and $f_2 + 2.5\text{ MHz}$, Referenced to the Carrier Channel Power)	IM3	—	–37	–35	dBc
Adjacent Channel Power Ratio ($V_{DD} = 26\text{ Vdc}$, $P_{out} = 9.5\text{ W Avg}$, 2–carrier N–CDMA, $I_{DQ} = 550\text{ mA}$, $f_1 = 1930\text{ MHz}$, $f_2 = 1932.5\text{ MHz}$ and $f_1 = 1987.5\text{ MHz}$, $f_2 = 1990\text{ MHz}$; ACPR measured in a 30 kHz Integrated Bandwidth Centered at $f_1 - 885\text{ kHz}$ and $f_2 + 885\text{ kHz}$)	ACPR	—	–51	–45	dBc
Input Return Loss ($V_{DD} = 26\text{ Vdc}$, $P_{out} = 9.5\text{ W Avg}$, 2–Carrier N–CDMA, $I_{DQ} = 550\text{ mA}$, $f_1 = 1930\text{ MHz}$, $f_2 = 1932.5\text{ MHz}$ and $f_1 = 1987.5\text{ MHz}$, $f_2 = 1990\text{ MHz}$)	IRL	—	–16	–9	dB
P_{out} , 1 dB Compression Point ($V_{DD} = 26\text{ Vdc}$, $I_{DQ} = 550\text{ mA}$, $f = 1990\text{ MHz}$)	P1dB	—	45	—	W
Output Mismatch Stress ($V_{DD} = 26\text{ Vdc}$, $P_{out} = 45\text{ W CW}$, $I_{DQ} = 550\text{ mA}$, $f = 1930\text{ MHz}$, VSWR = 5:1, All Phase Angles at Frequency of Tests)	Ψ	No Degradation In Output Power Before and After Test			

(1) Part is internally matched both on input and output.



Z1	1.336" x 0.081" Microstrip	Z9	0.519" x 0.254" Microstrip
Z2	0.693" x 0.081" Microstrip	Z10	0.874" x 0.081" Microstrip
Z3	1.033" x 0.047" Microstrip	Z11	0.645" x 0.081" Microstrip
Z4	0.468" x 0.047" Microstrip	Board	3" x 5" Copper Clad PCB, Arlon GX0300-55-22, $\epsilon_r = 2.55$
Z5	0.271" x 0.460" Microstrip	Printed Circuit Board	CMR Part Number 19045PC5.SKF
Z6	0.263" x 0.930" Microstrip		
Z7	1.165" x 0.047" Microstrip		
Z8	0.216" x 0.047" Microstrip		

NOTE: Z3, Z4, Z7, Z8 lengths and component placement tolerances are $\pm 0.050''$.
 Zx lengths are microstrip lengths between components, center-line to center-line.
 All component and z-length tolerances are $\pm 0.015''$, except as noted.

Figure 1. 1930 – 1990 MHz 2-Carrier N-CDMA Test Circuit Schematic

Table 1. 1930 – 1990 MHz 2-Carrier N-CDMA Test Circuit Component Designations and Values

Designators	Description
B1, B2	0.120" x 0.333" x 0.100", Surface Mount Ferrite Beads, Fair Rite #2743019446
C1, C2	10 μ F, 35 V Tantalum Surface Mount Chip Capacitors, Kemet #T495X106K035AS4394
C3, C11	0.1 μ F, Chip Capacitors, Kemet #CDR33BX104AKWS
C4, C8	24 pF, ATC RF Chip Capacitors, B Case, ATC #100B240JP500X
C5	470 pF, ATC RF Chip Capacitor, B Case, ATC #100B471JP200X
C6, C7	11 pF, ATC RF Chip Capacitors, B Case, ATC #100B110JP500X
C9, C10, C12	22 μ F, 35 V Tantalum Surface Mount Chip Capacitors, Kemet #T491X226K035AS4394
C13	8.2 pF, ATC RF Chip Capacitor, B Case, ATC #100B8R2CP500X
R1	560 k Ω , 1/4 W Chip Resistor (0.08" x 0.13")
R2, R3, R4, R5	8.2 Ω , 1/4 W Chip Resistor (0.08" x 0.13"), Garrett Instruments #RM73B2B110JT
W1, W2	Solid Copper Buss Wire, 16 AWG
WS1, WS2	Beryllium Copper Wear Blocks (0.005" x 0.150" x 0.350") Nominal
	Brass Banana Jack and Nut
	Red Banana Jack and Nut
	Green Banana Jack and Nut
	Type "N" Jack Connectors, Omni-Spectra #3052-1648-10
	4-40 Ph Head Screws, 0.125" long
	4-40 Ph Head Screws, 0.312" long
	4-40 Ph Head Screws, 0.625" long
	4-40 Ph Rec. Hd. Screws, 0.625" long

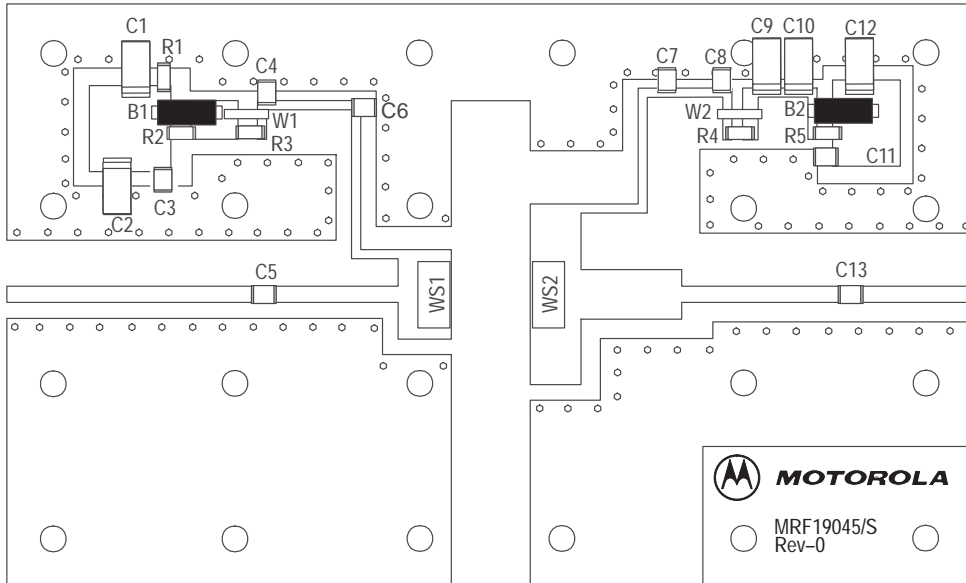


Figure 2. 1930 – 1990 MHz 2-Carrier N-CDMA Test Circuit Components Layout

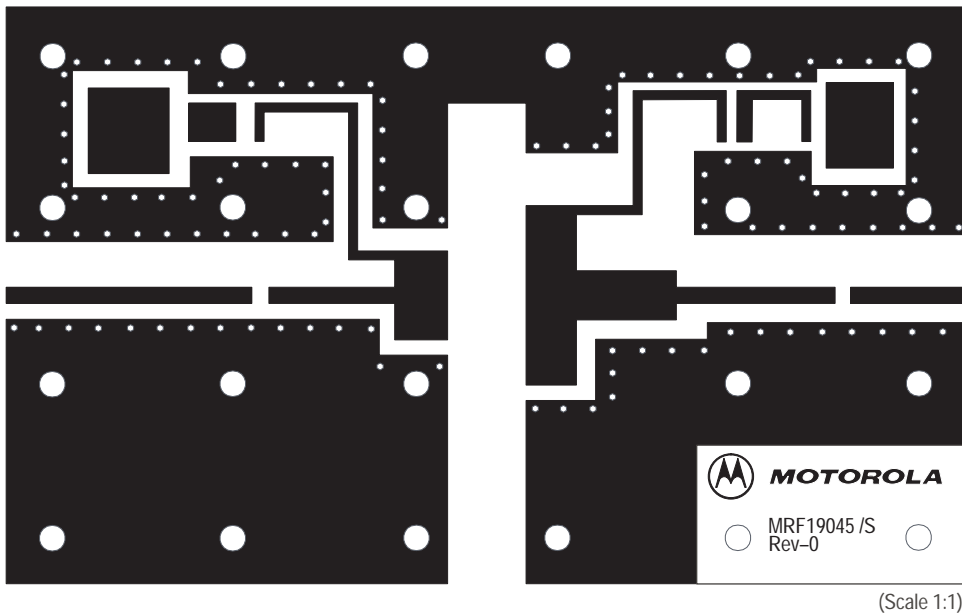


Figure 3. 1930 – 1990 MHz 2-Carrier N-CDMA Test Circuit Photomaster
(Reduced 18% in printed data book, DL110/D)

TYPICAL CHARACTERISTICS

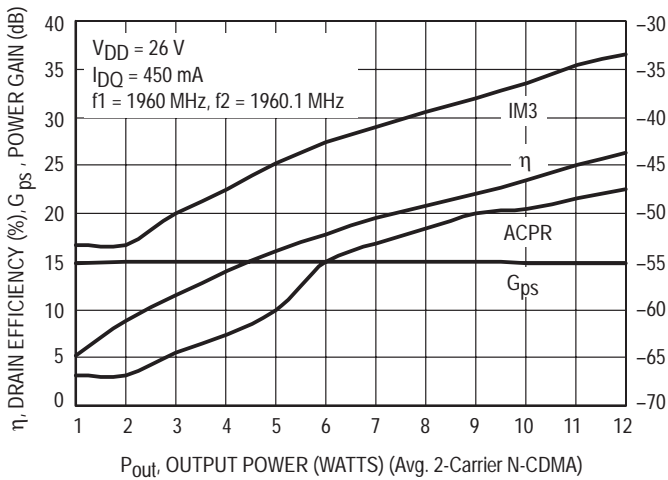


Figure 4. 2-Carrier N-CDMA ACPR, IM3, Power Gain and Drain Efficiency versus Output Power

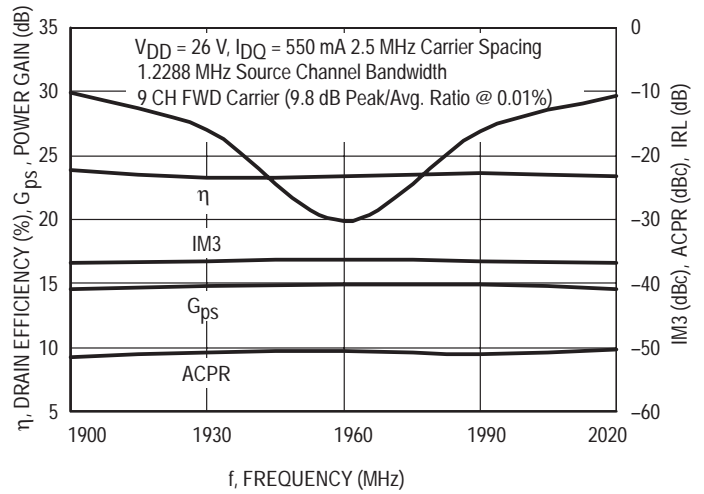


Figure 5. 2-Carrier N-CDMA ACPR, IM3, Power Gain, IRL and Drain Efficiency versus Output Power

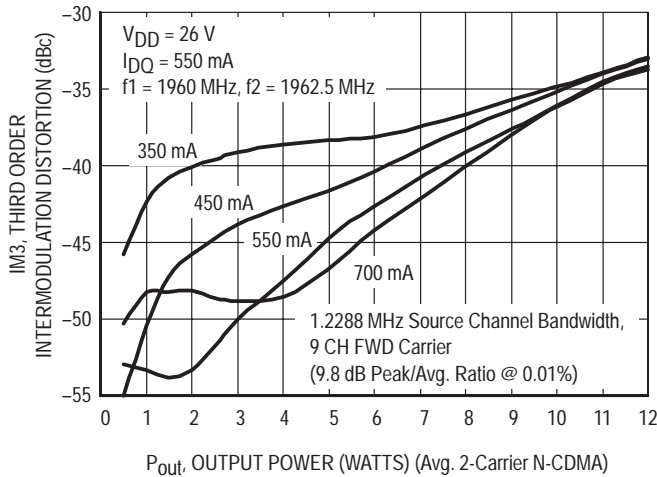


Figure 6. 2-Carrier N-CDMA IM3 versus Output Power

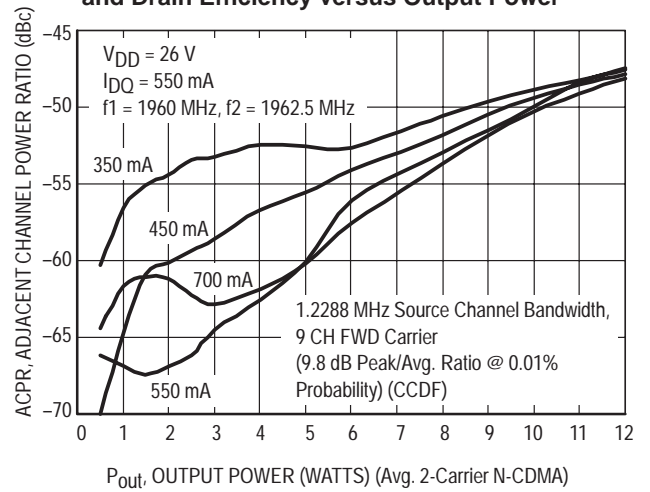


Figure 7. 2-Carrier N-CDMA ACPR versus Output Power

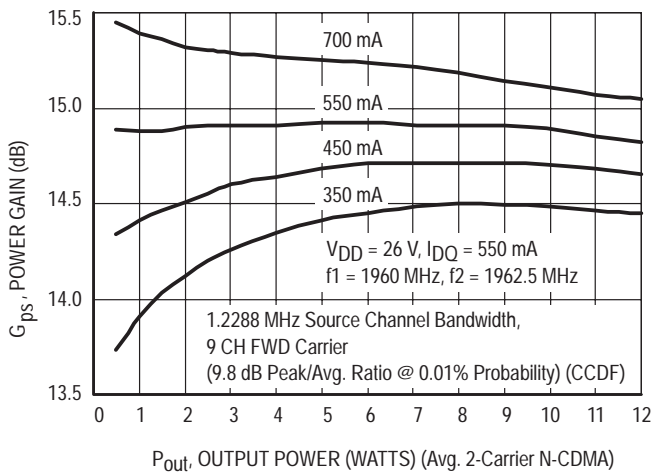


Figure 8. 2-Carrier N-CDMA Power Gain versus Output Power

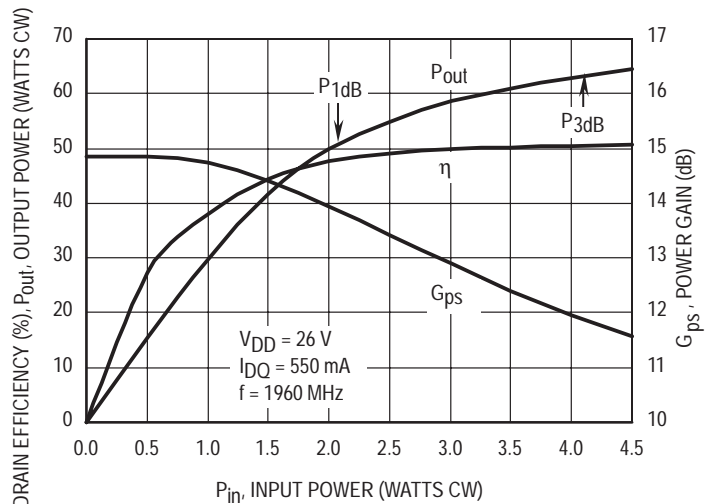


Figure 9. CW Output Power, Power Gain and Drain Efficiency versus Input Power

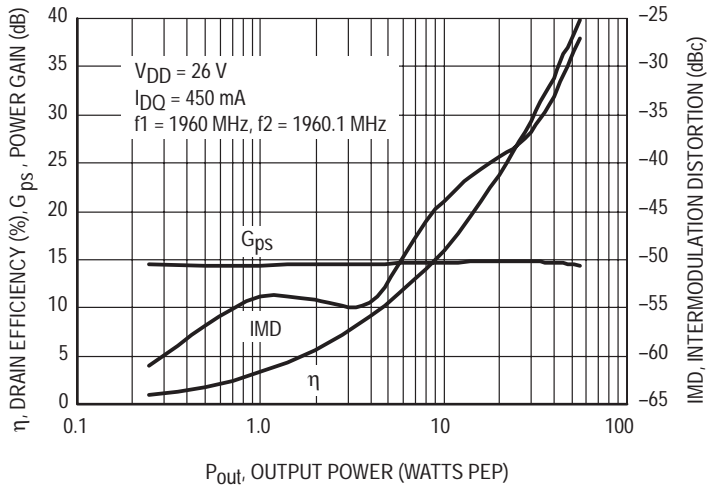


Figure 10. CW Two-Tone Power Gain, IMD and Drain Efficiency versus Output Power

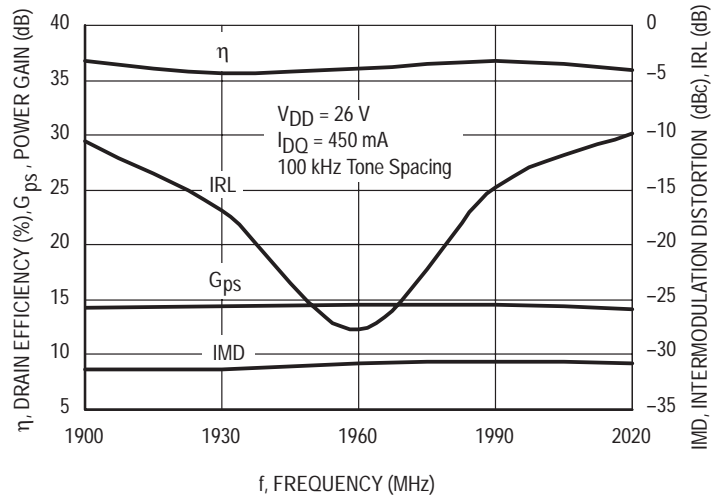


Figure 11. CW Two-Tone Power Gain, Input Return Loss, IMD and Drain Efficiency versus Frequency

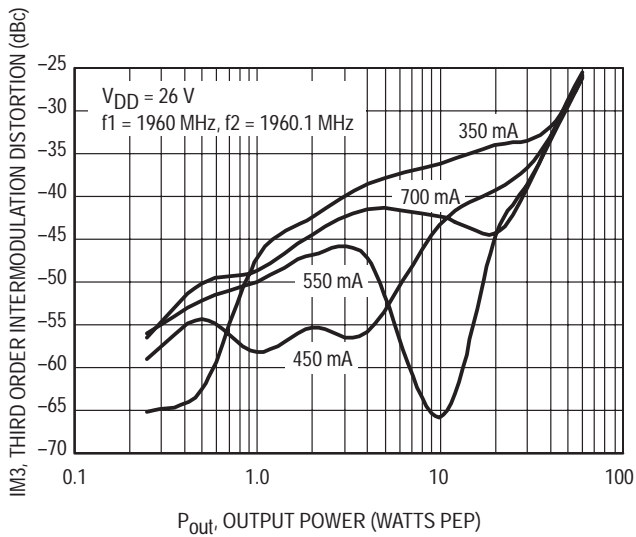


Figure 12. CW Two-Tone Intermodulation Distortion versus Output Power

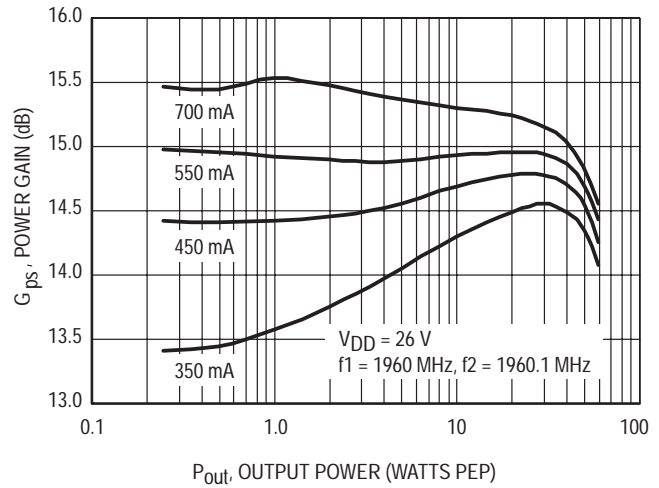


Figure 13. CW Two-Tone Power Gain versus Output Power

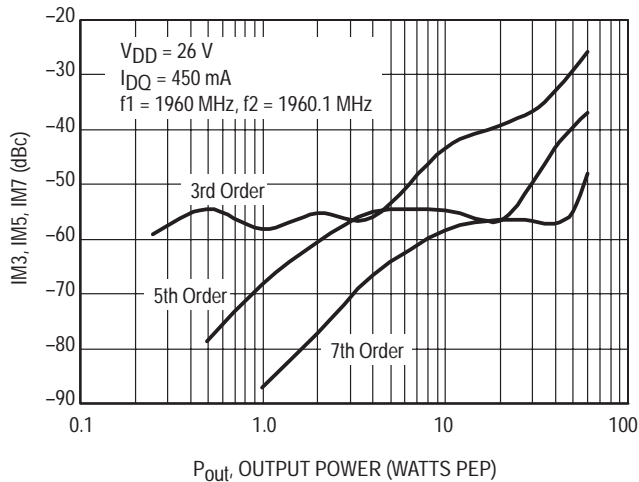


Figure 14. CW Two-Tone Intermodulation Distortion Products versus Output Power

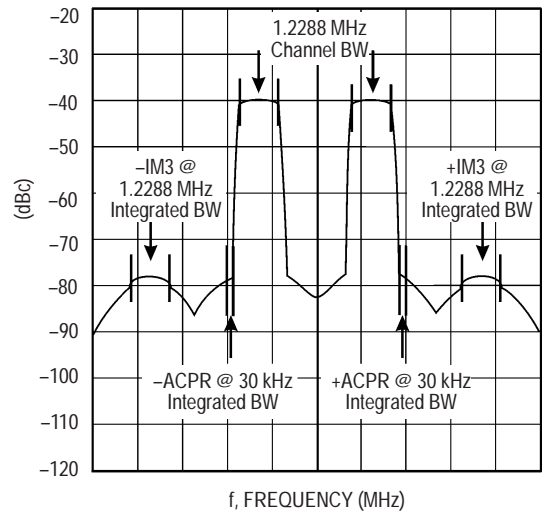
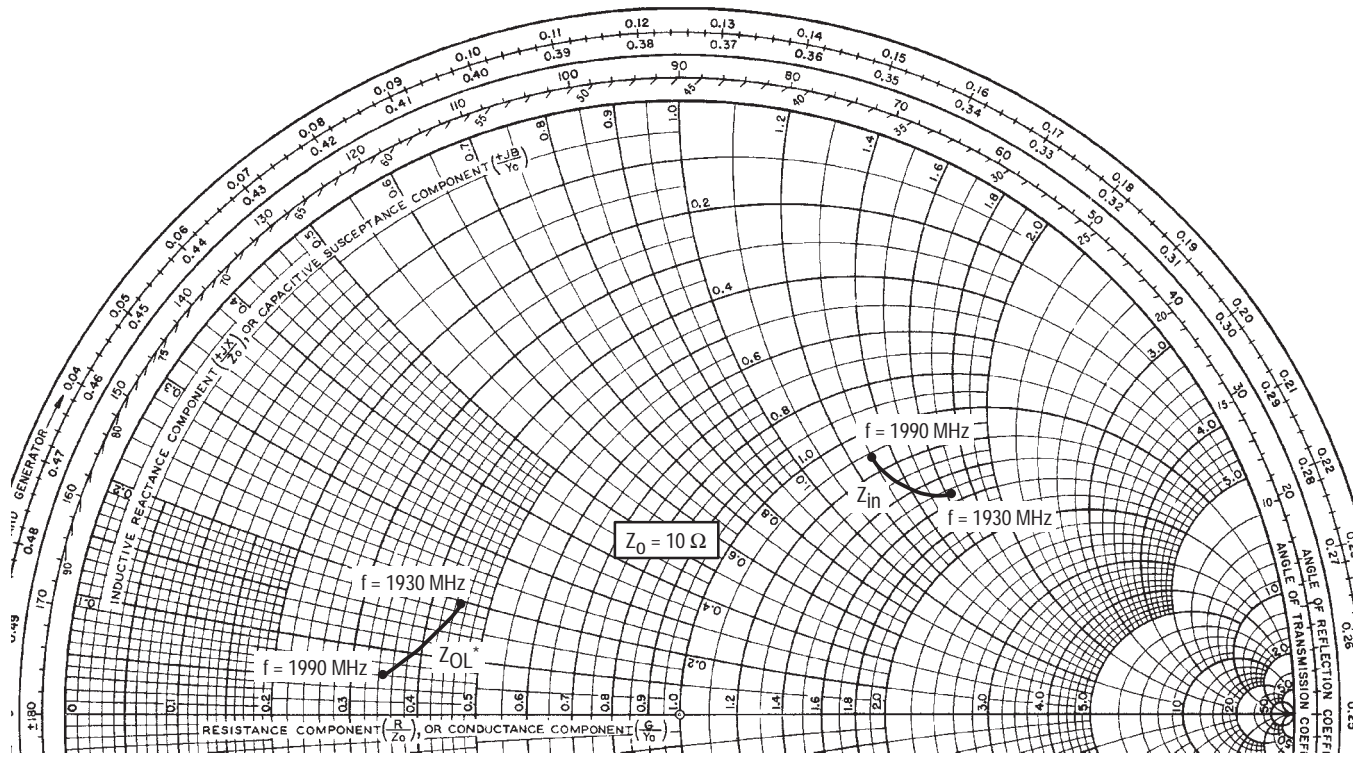


Figure 15. 2-Carrier N-CDMA Spectrum



$V_{DD} = 26\text{ V}$, $I_{DQ} = 550\text{ mA}$, $P_{out} = 9\text{ W}_{avg}$,
 2-Carrier N-CDMA

f MHz	Z_{in} Ω	Z_{OL}^* Ω
1930	$15.52 + j16.5$	$4.52 + j1.86$
1960	$14.24 + j14.44$	$3.85 + j1.04$
1990	$11.11 + j13.01$	$3.44 + j0.69$

Z_{in} = Complex conjugate of the optimum broadband source impedance.

Z_{OL}^* = Complex conjugate of the optimum load impedance at a given output power, voltage, IMD, bias current and frequency.

Note 1: Z_{OL}^* was chosen based on tradeoffs between gain, output power, drain efficiency and intermodulation distortion.

Note 2: Measurements were taken on the MRF19045 broadband 2-carrier N-CDMA test circuit, with SMA Launchers.

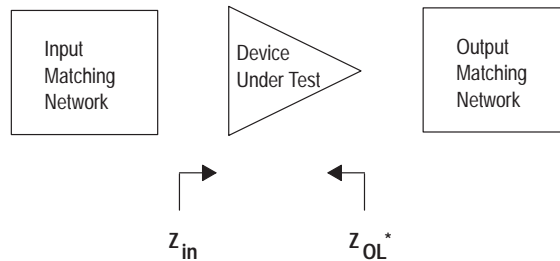


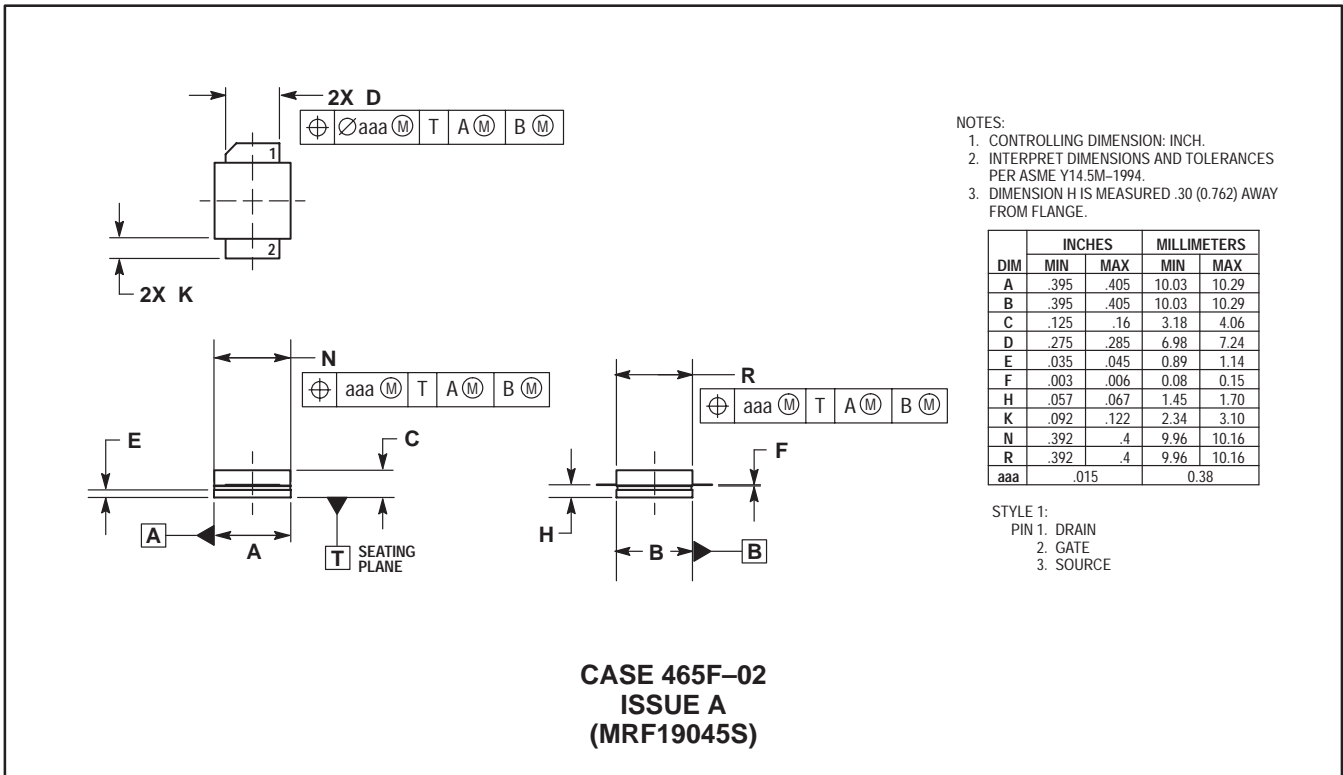
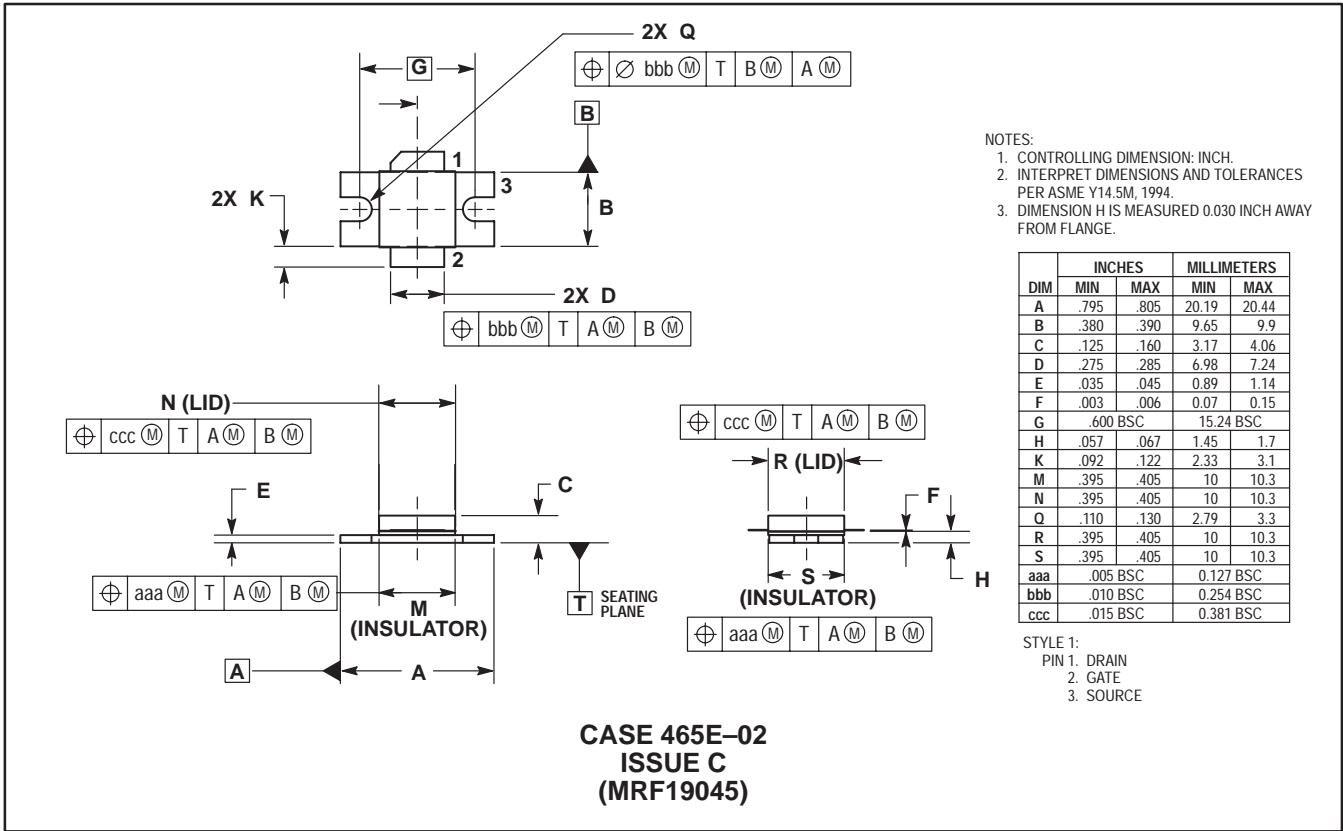
Figure 16. Series Equivalent Input and Output Impedance


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PACKAGE DIMENSIONS



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